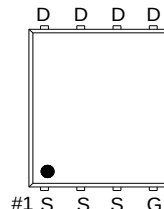
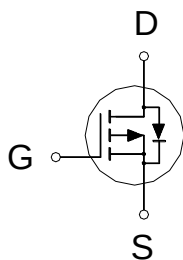


PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
-100V	75m Ω	-19A



1. GATE
2. DRAIN
3. SOURCE


ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^{\circ}\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	-100	V
Gate-Source Voltage		V_{GS}	± 25	V
Continuous Drain Current	$T_C = 25\text{ }^{\circ}\text{C}$	I_D	-19	A
	$T_C = 100\text{ }^{\circ}\text{C}$		-12	
Pulsed Drain Current ¹		I_{DM}	-45	
Continuous Drain Current	$T_A = 25\text{ }^{\circ}\text{C}$	I_D	-4.4	
	$T_A = 70\text{ }^{\circ}\text{C}$		-3.5	
Avalanche Current		I_{AS}	-15	
Avalanche Energy	$L = 1\text{mH}$	E_{AS}	113	mJ
Power Dissipation	$T_C = 25\text{ }^{\circ}\text{C}$	P_D	60	W
	$T_C = 100\text{ }^{\circ}\text{C}$		24	
Power Dissipation ³	$T_A = 25\text{ }^{\circ}\text{C}$	P_D	3.1	W
	$T_A = 70\text{ }^{\circ}\text{C}$		2	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	$^{\circ}\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10\text{s}$	$R_{\theta JA}$		40	$^{\circ}\text{C} / \text{W}$
Junction-to-Ambient ²	Steady-State	$R_{\theta JA}$		78	
Junction-to-Case	Steady-State	$R_{\theta JC}$		2.1	

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}\text{C}$.

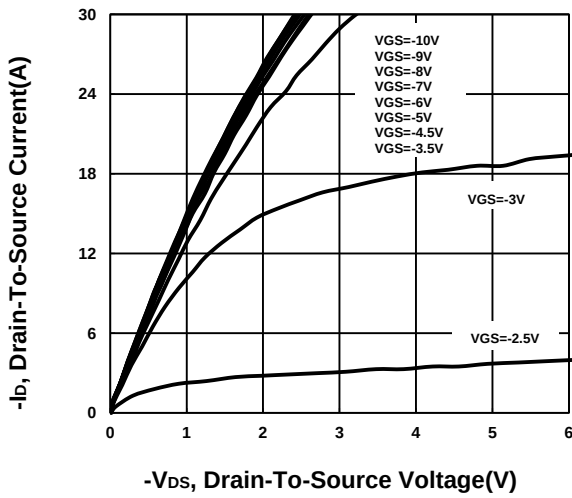
³The Power dissipation is based on $R_{\theta JA}$ $t \leq 10\text{s}$ value.

ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^{\circ}\text{C}$, Unless Otherwise Noted)

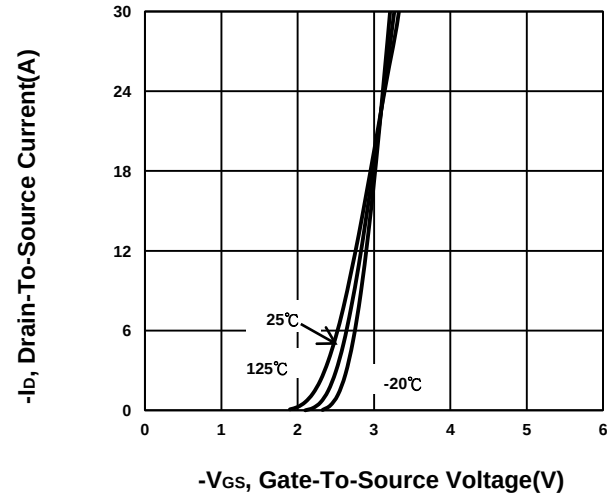
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = -250μA	-100			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250μA	-1.3	-1.8	-2.3	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0V, V _{GS} = ±25V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -100V, V _{GS} = 0V			-1	μA
		V _{DS} = -100V, V _{GS} = 0V, T _J = 55 °C			-10	
Drain-Source On-State Resistance ¹	R _{DS(ON)}	V _{GS} = -4.5V, I _D = -10A		62	85	mΩ
		V _{GS} = -10V, I _D = -10A		57	75	
Forward Transconductance ¹	g _{fs}	V _{DS} = -5V, I _D = -10A		32		S
DYNAMIC						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = -50V, f = 1MHz		2301		pF
Output Capacitance	C _{oss}			117		
Reverse Transfer Capacitance	C _{rss}			82		
Gate Resistance	R _g	V _{GS} =0V, V _{DS} = 0V, f = 1MHz		7.8		Ω
Total Gate Charge ²	Q _g (V _{GS} =-10V)	V _{DS} = -50V , V _{GS} = -10V, I _D = -10A		48		nC
	Q _g (V _{GS} =-4.5V)			25		
Gate-Source Charge ²	Q _{gs}			6		
Gate-Drain Charge ²	Q _{gd}			12		
Turn-On Delay Time ²	t _{d(on)}	V _{DS} = -50V , I _D ≅ -10A, V _{GS} = -10V, R _{GEN} =6Ω		11		nS
Rise Time ²	t _r			38		
Turn-Off Delay Time ²	t _{d(off)}			116		
Fall Time ²	t _f			86		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _J = 25 °C)						
Continuous Current	I _S				-19	A
Forward Voltage ¹	V _{SD}	I _F = -10A, V _{GS} = 0V			-1.2	V
Reverse Recovery Time	t _{rr}	I _F = -10A, dI _F /dt = 100A / μS		51		nS
Reverse Recovery Charge	Q _{rr}			52		nC

¹Pulse test : Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.

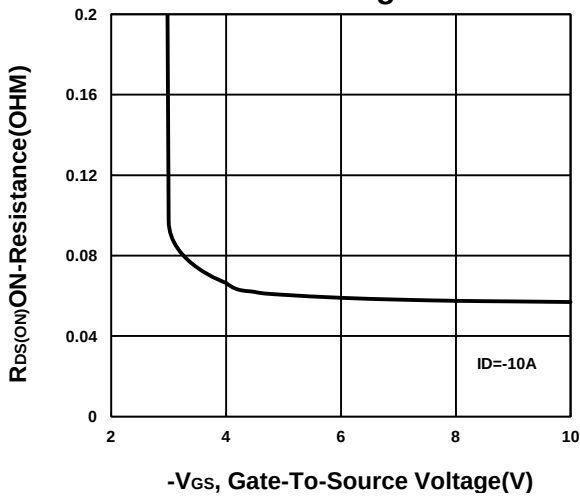
Output Characteristics



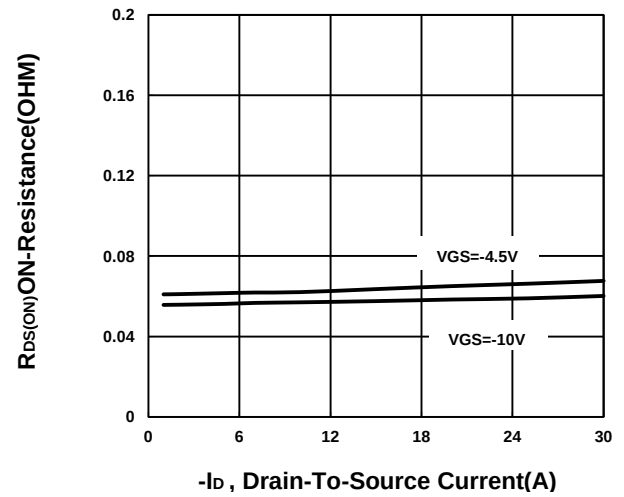
Transfer Characteristics



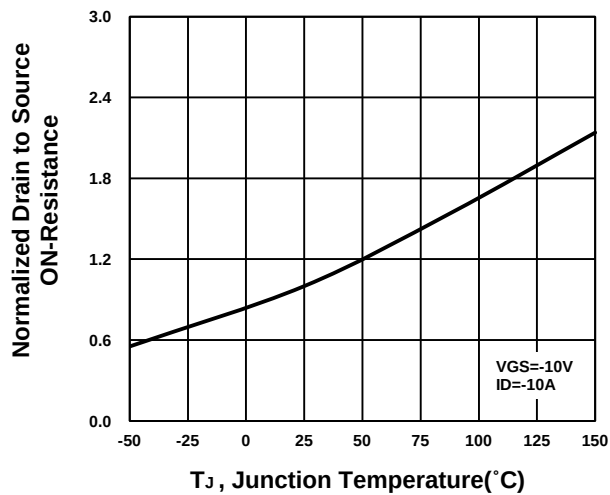
On-Resistance VS Gate-To-Source Voltage



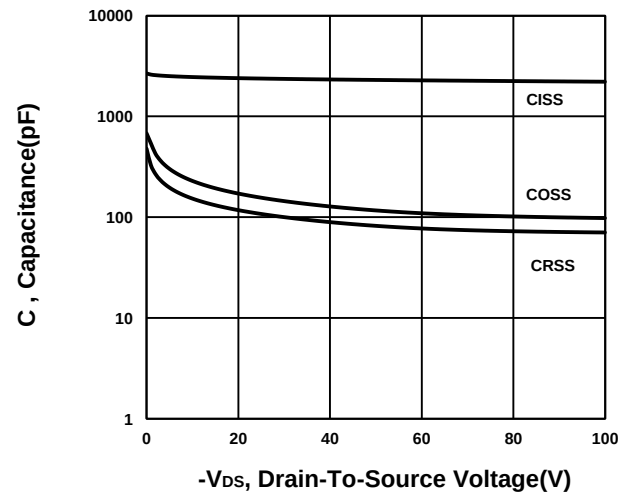
On-Resistance VS Drain Current



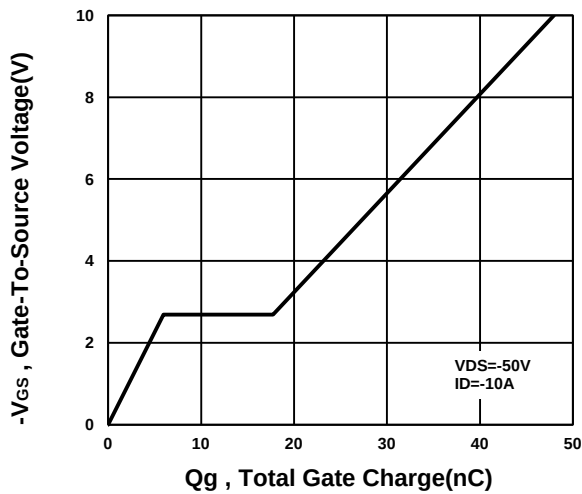
On-Resistance VS Temperature



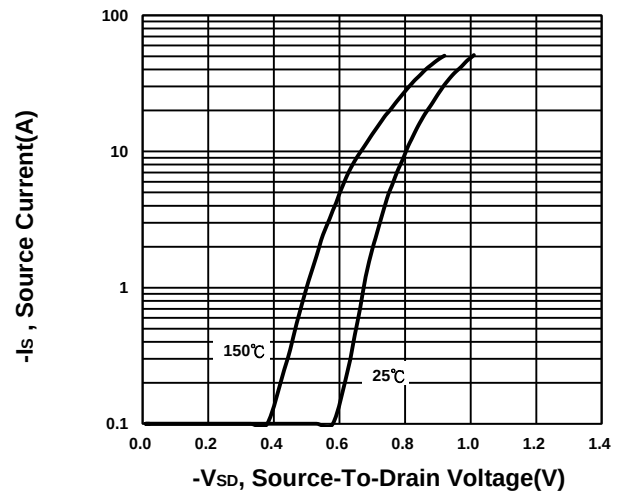
Capacitance Characteristic



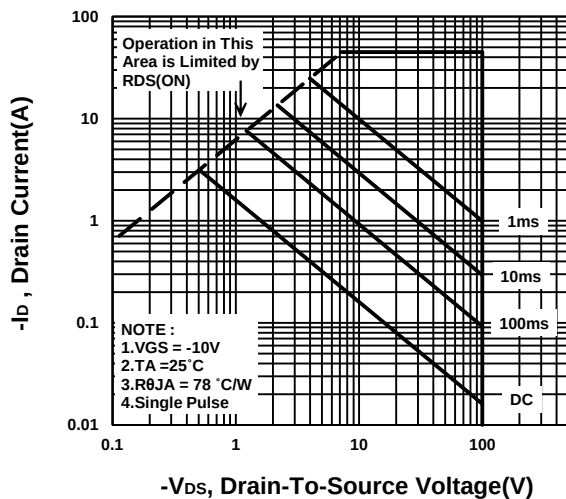
Gate charge Characteristics



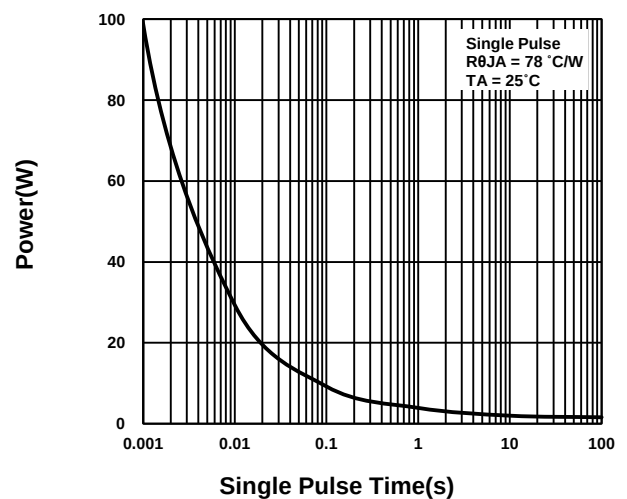
Source-Drain Diode Forward Voltage



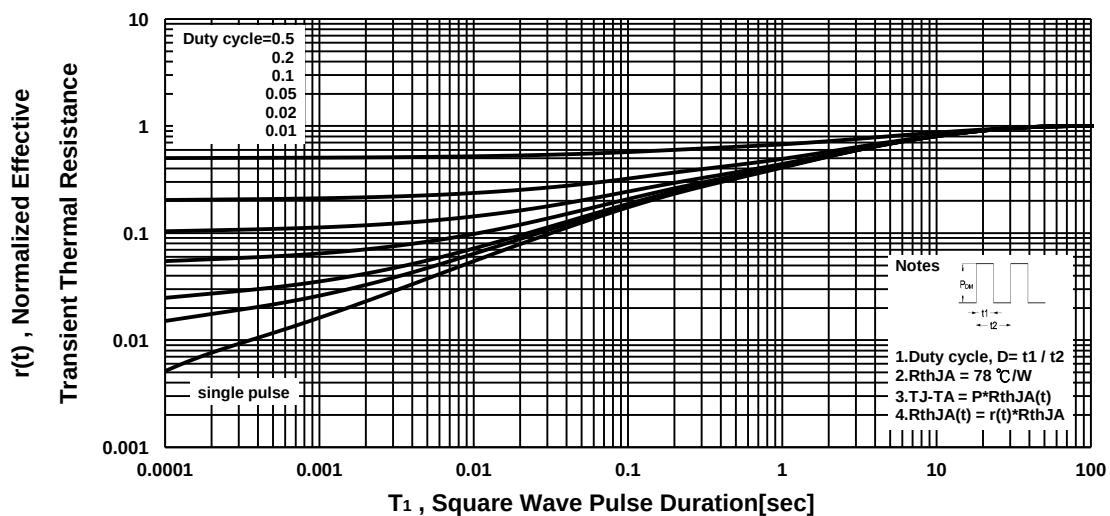
Safe Operating Area



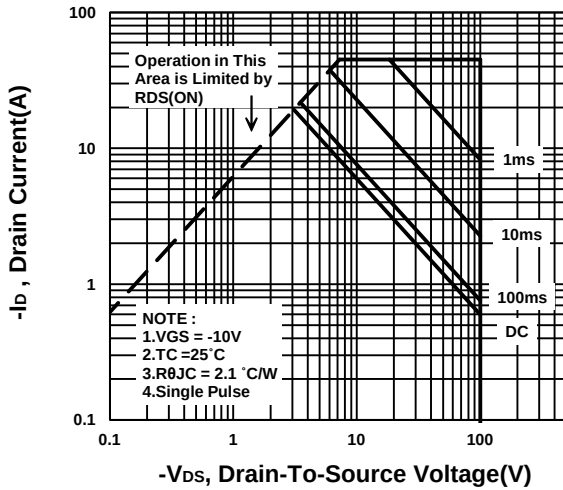
Single Pulse Maximum Power Dissipation



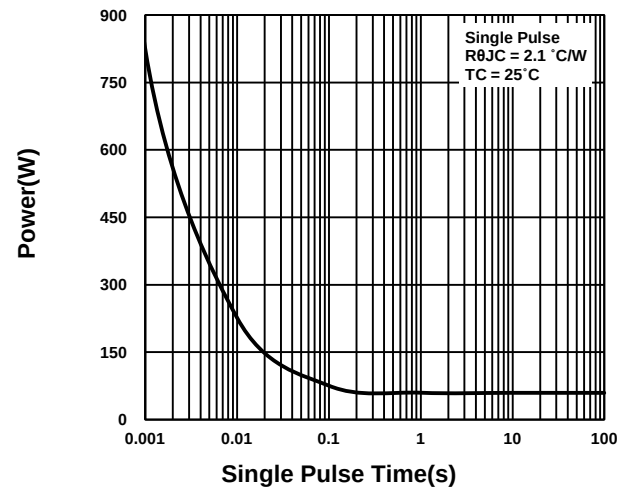
Transient Thermal Response Curve



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

